Search Notes (continued)



Applic	cation	Contr	ol No.
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Applicant(s)/Patent under Reexamination

LYNCH ET AL.
Art Unit

09/736,223 Examiner

Chau Nguyen

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SEARCHED				
Class	Subclass	Date	Examiner	
715	513-514	10/19/2005	CN	
715	516-517	10/19/2005	CN	
715	522-523	10/19/2005	CN	
709	200-201	10/19/2005	CN	
709	203	10/19/2005	, CN	
709	213	10/19/2005	CN	
709	217	10/19/2005	CN	
713	100	10/19/2005	CN	
717	176	10/19/2005	CN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NO (INCLUDING SEARCH)
• ;	DATE	EXMR
Updated Search on East Reports	10/25/2005	CN
	10/26/2005	CN
NPL Search on IEEE Database	10/27/2005	CN
Updated Search on East Reports	4/25/2006	
Inventor Search on East Reports	4/25/2006	
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